

N-Channel Enhancement Mode Power MOSFET

Description

The HM50N06A uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications.

General Features

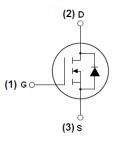
- V_{DS} =60V, I_{D} =50A $R_{DS(ON)}$ <20m Ω @ V_{GS} =10V
- High density cell design for ultra low Rdson
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high E_{AS}
- Excellent package for good heat dissipation
- Special process technology for high ESD capability

Application

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply

100% UIS TESTED!

100% AVds TESTED!



Schematic diagram



Marking and pin Assignment



HC!&&\$!' @top view

Package Marking and Ordering Information

| Device | Marking | Device | Device Package | Reel Size | Tape width | Quantity |
|--------|---------|----------|----------------|-----------|------------|----------|
| HM5 | 0N06A | HM50N06A | TO-220-3L | - | - | - |

Absolute Maximum Ratings (T_C=25℃unless otherwise noted)

| Parameter | Symbol | Limit | Unit |
|--|-----------------------|------------|------------|
| Drain-Source Voltage | V _{DS} | 60 | V |
| Gate-Source Voltage | V _{GS} | ±20 | V |
| Drain Current-Continuous | I _D | 50 | Α |
| Drain Current-Continuous(T _C =100 °C) | I _D (100℃) | 35.4 | Α |
| Pulsed Drain Current | I _{DM} | 200 | Α |
| Maximum Power Dissipation | P _D | 85 | W |
| Derating factor | | 0.57 | W/℃ |
| Single pulse avalanche energy (Note 5) | E _{AS} | 300 | mJ |
| Operating Junction and Storage Temperature Range | T_{J} , T_{STG} | -55 To 175 | $^{\circ}$ |



Thermal Characteristic

| Thermal Resistance, Junction-to-Case ^(Note 2) | R _{eJC} | 1.8 | °C/W |
|--|------------------|-----|------|
|--|------------------|-----|------|

Electrical Characteristics (Tc=25 ℃ unless otherwise noted)

| Parameter | Symbol | Condition | Min | Тур | Max | Unit |
|------------------------------------|---------------------|--|-----|------|------|------|
| Off Characteristics | • | | • | | | |
| Drain-Source Breakdown Voltage | BV _{DSS} | V _{GS} =0V I _D =250μA | 60 | - | - | V |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} =60V,V _{GS} =0V | - | - | 1 | μΑ |
| Gate-Body Leakage Current | I _{GSS} | V _{GS} =±20V,V _{DS} =0V | - | - | ±100 | nA |
| On Characteristics (Note 3) | | | | | | |
| Gate Threshold Voltage | $V_{GS(th)}$ | V _{DS} =V _{GS} ,I _D =250μA | 1.4 | 1.9 | 2.5 | V |
| Drain-Source On-State Resistance | R _{DS(ON)} | V _{GS} =10V, I _D =20A | - | 14 | 20 | mΩ |
| Forward Transconductance | g FS | V _{DS} =5V,I _D =20A | 18 | - | - | S |
| Dynamic Characteristics (Note4) | • | | • | | | |
| Input Capacitance | C _{lss} | \/ 20\/\/ 0\/ | - | 2050 | - | PF |
| Output Capacitance | C _{oss} | V_{DS} =30V, V_{GS} =0V, F=1.0MHz | - | 158 | - | PF |
| Reverse Transfer Capacitance | C _{rss} | F=1.0WID2 | - | 120 | - | PF |
| Switching Characteristics (Note 4) | • | | • | | | |
| Turn-on Delay Time | t _{d(on)} | | - | 7.4 | - | nS |
| Turn-on Rise Time | t _r | V_{DD} =30V, R_L =6.7 Ω | - | 5.1 | - | nS |
| Turn-Off Delay Time | t _{d(off)} | V_{GS} =10 V , R_{G} =3 Ω | - | 28.2 | - | nS |
| Turn-Off Fall Time | t _f | | - | 5.5 | - | nS |
| Total Gate Charge | Qg | \/ -20\/ L -20A | - | 50 | | nC |
| Gate-Source Charge | Q _{gs} | $V_{DS}=30V,I_{D}=20A,$ $V_{GS}=10V$ | - | 6 | | nC |
| Gate-Drain Charge | Q_{gd} | V _{GS} =10V | - | 15 | | nC |
| Drain-Source Diode Characteristics | • | | • | | | |
| Diode Forward Voltage (Note 3) | V _{SD} | V _{GS} =0V,I _S =20A | - | | 1.2 | V |
| Diode Forward Current (Note 2) | Is | | - | - | 50 | Α |
| Reverse Recovery Time | t _{rr} | TJ = 25°C, IF =20A | - | 28 | - | nS |
| Reverse Recovery Charge | Qrr | $di/dt = 100A/\mu s^{(Note3)}$ | - | 40 | - | nC |
| Forward Turn-On Time | t _{on} | Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD) | | | | |

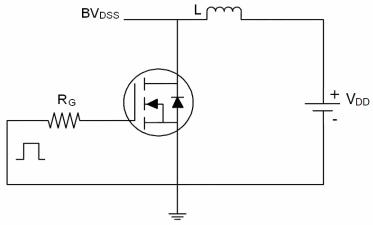
Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- **2.** Surface Mounted on FR4 Board, $t \le 10$ sec.
- 3. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- **4.** Guaranteed by design, not subject to production
- **5.** EAS condition : Tj=25 $^{\circ}$ C,VDD=30V,VG=10V,L=0.5mH,Rg=25 Ω

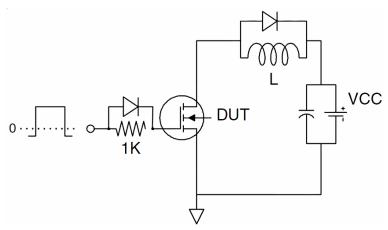


Test Circuit

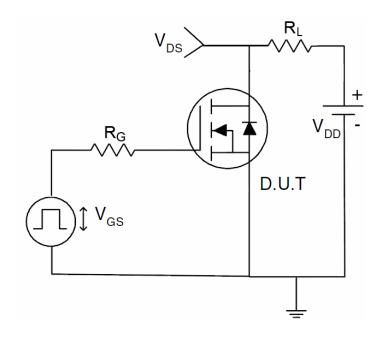
1) E_{AS} test Circuit



2) Gate charge test Circuit



3) Switch Time Test Circuit





Typical Electrical and Thermal Characteristics (Curves)

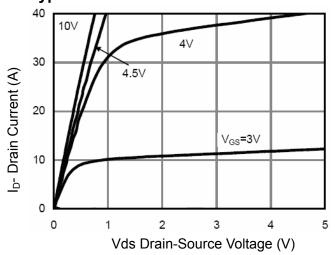


Figure 1 Output Characteristics

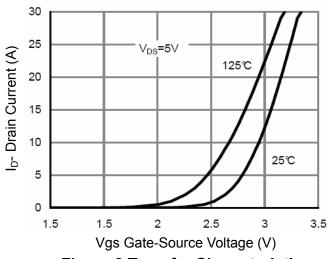


Figure 2 Transfer Characteristics

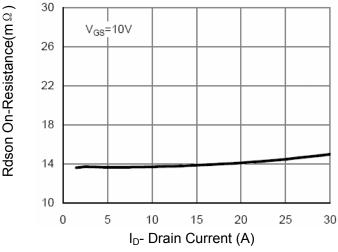


Figure 3 Rdson- Drain Current

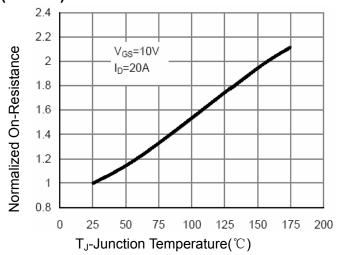


Figure 4 Rdson-Junction Temperature

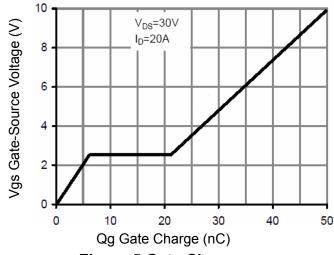


Figure 5 Gate Charge

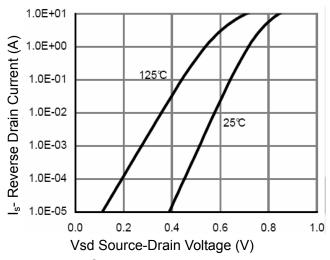


Figure 6 Source- Drain Diode Forward



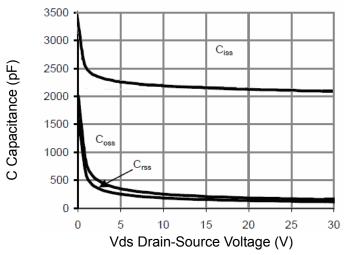


Figure 7 Capacitance vs Vds

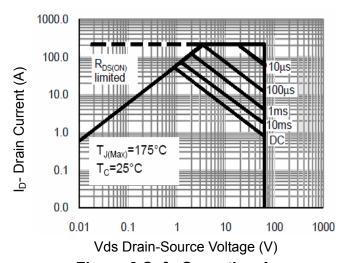


Figure 8 Safe Operation Area

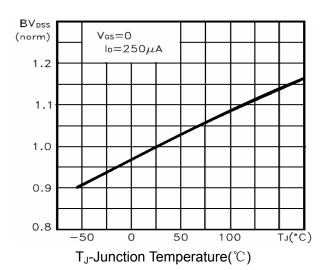


Figure 9 BV_{DSS} vs Junction Temperature

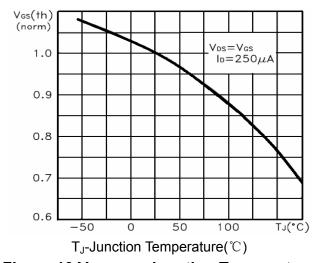


Figure 10 V_{GS(th)} vs Junction Temperature

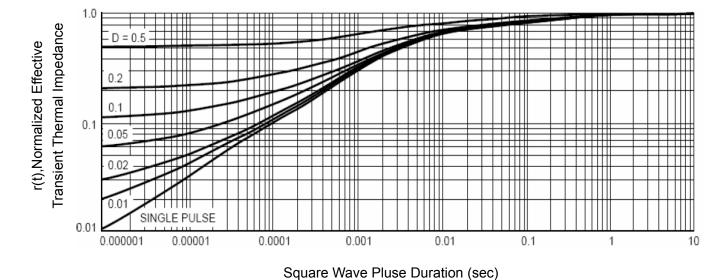
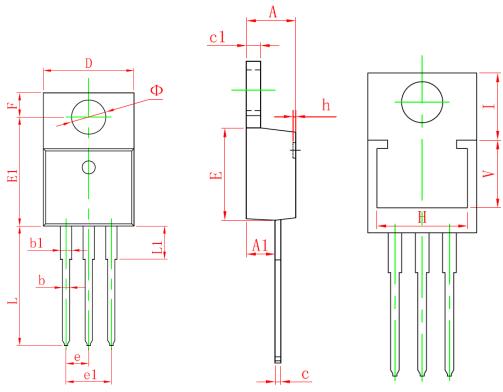


Figure 11 Normalized Maximum Transient Thermal Impedance



TO-220-3L Package Information



| Symbol | Dimensions | In Millimeters | Dimensions In Inches | | | |
|--------|--------------|----------------|----------------------|------------|--|--|
| Symbol | Min | Max | Min | Max | | |
| A | 4.470 | 4.670 | 0.176 | 0.184 | | |
| A1 | 2.520 | 2.820 | 0.099 | 0.111 | | |
| b | 0.710 | 0.910 | 0.028 | 0.036 | | |
| b1 | 1.170 | 1.370 | 0.046 | 0.054 | | |
| с | 0.330 | 0.650 | 0.013 | 0.026 | | |
| c1 | 1.200 | 1.400 | 0.047 | 0.055 | | |
| D | 10.010 | 10.350 | 0.394 | 0.407 | | |
| E | 8.500 | 8.900 | 0.335 | 0.350 | | |
| E1 | 12.060 | 12.460 | 0.475 | 0.491 | | |
| e | 2.540 (TYP.) | | 0.100 (TYP.) | | | |
| e1 | 4.980 | 5.180 | 0.196 | 0.204 | | |
| F | 2.590 | 2.890 | 0.102 | 0.114 | | |
| Н | 8.440 REF. | | 0.332 REF. | | | |
| h | 0.000 | 0.300 | 0.000 | 0.012 | | |
| L | 13.400 | 13.800 | 0.528 | 0.543 | | |
| L1 | 3.560 | 3.960 | 0.140 | 0.156 | | |
| V | 6.360 REF. | | 0.250 | .250 REF. | | |
| I | 6.30 | 6.300 REF. | | 0.248 REF. | | |
| Φ | 3.735 | 3.935 | 0.147 | 0.155 | | |



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